 Search Notes		
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	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/729,569	KUSAKABE ET AL.
Ī	Examiner	Art Unit
	Ellen C. Tran	2134

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Class	Subclass	Date	Examiner
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	6/1/2006	ECT